



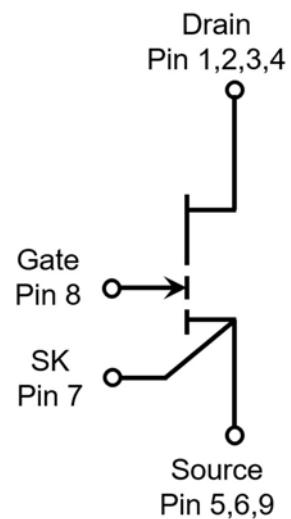
## General description

650V GaN-on-Silicon Enhancement-mode  
Power Transistor in Dual Flat No-lead  
Package (DFN) with 5 mm × 6 mm size.



## Features

- Enhancement-mode transistor - normally-OFF power switch
- Ultra-high switching frequency
- No reverse-recovery charge
- Low gate charge, low output charge
- Qualified for industrial applications according to JEDEC Standards
- ESD safeguard
- RoHS, Pb-free, REACH-compliant



## Applications

- AC-DC converters
- DC-DC converters
- Totem pole PFC
- Fast battery charging
- High-density power conversion
- High-efficiency power conversion

|               |            |
|---------------|------------|
| Gate          | 8          |
| Drain         | 1, 2, 3, 4 |
| Kelvin Source | 7          |
| Source        | 5, 6, 9    |



## Maximum ratings

at  $T_j = 25^\circ\text{C}$  unless otherwise specified. Continuous application of maximum ratings can deteriorate transistor lifetime.

For further information, contact CloudSemi sales office.

**Table 3 Maximum rating**

| Parameters                                   | Symbols                    | Values |      |      | Units | Notes/Test Conditions  |
|--|----------------------------|--------|------|------|-------|--|
|  |                            | Min.   | Typ. | Max. |       |  |
| Drain-source voltage                         | $V_{DS, \text{max}}$       | -      | -    | 650  | V     | $V_{GS} = 0 \text{ V}$ , $I_D = 10 \mu\text{A}$  |
| Drain-source voltage transient <sup>1</sup>  | $V_{DS, \text{transient}}$ | -      | -    | 750  | V     | $V_{GS} = 0 \text{ V}$ , $V_{DS} = 750 \text{ V}$  |
| Continuous current, drain-source             | $I_D$                      | -      | -    | 10   | A     | $T_c = 25^\circ\text{C}$   |
| Pulsed current, drain-source <sup>2</sup>    | $I_{D, \text{pulse}}$      | -      | -    | 18   | A     | $T_c = 25^\circ\text{C}$ ; $V_G = 6 \text{ V}$   |
| Pulsed current, drain-source <sup>2</sup>    | $I_{D, \text{pulse}}$      | -      | -    | 10   | A     | $T_c = 125^\circ\text{C}$ ; $V_G = 6 \text{ V}$  |
| Gate-source voltage, continuous <sup>3</sup> | $V_{GS}$                   | -1.4   | -    | +7   | V     | $T_j = -55^\circ\text{C}$ to $150^\circ\text{C}$   |
| Gate-source voltage, pulsed                  | $V_{GS, \text{pulse}}$     | -      | -    | +10  | V     | $T_j = -55^\circ\text{C}$ to $150^\circ\text{C}$ ;<br>$t_{\text{pulse}} = 50 \text{ ns}$ , $f = 100 \text{ kHz}$ ;<br>open drain |
| Power dissipation                            | $P_{\text{tot}}$           | -      | -    | 75   | W     | $T_c = 25^\circ\text{C}$   |
| Operating temperature                        | $T_j$                      | -55    | -    | +150 | °C    |  |
| Storage temperature                          | $T_{\text{stg}}$           | -55    | -    | +150 | °C    |  |

1.  $V_{DS, \text{transient}}$  is intended for surge rating during non-repetitive events,  $t_{\text{pulse}} < 1 \mu\text{s}$ .

2. Pulse width = 10  $\mu\text{s}$ .

3. The minimum  $V_{GS}$  is clamped by ESD protection circuit, as shown in Figure 8.

## Thermal characteristics

**Table 4 Thermal characteristics**

| Parameters                        | Symbols           | Values |      |      | Units | Notes/Test Conditions |
|-----------------------------------|-------------------|--------|------|------|-------|-----------------------|
|                                   |                   | Min.   | Typ. | Max. |       |                       |
| Thermal resistance, junction-case | $R_{\text{thJC}}$ | -      | -    | 1.65 | °C/W  |                       |
| Reflow soldering temperature      | $T_{\text{sold}}$ | -      | -    | 260  | °C    | MSL3                  |



## Electrical characteristics

at  $T_j = 25^\circ\text{C}$ , unless specified otherwise.

**Table 5 Static characteristics**

| Parameters                       | Symbols      | Values |      |      | Units            | Notes/Test Conditions   |
|----------------------------------|--------------|--------|------|------|------------------|---|
|                                  |              | Min.   | Typ. | Max. |                  |   |
| Gate threshold voltage           | $V_{GS(TH)}$ | 1.2    | 1.6  | 2.5  | V                | $I_D = 11 \text{ mA}; V_{DS} = V_{GS}; T_j = 25^\circ\text{C}$          |
|                                  |              | -      | 1.6  | -    |                  | $I_D = 11 \text{ mA}; V_{DS} = V_{GS}; T_j = 125^\circ\text{C}$         |
| Drain-source leakage current     | $I_{DSS}$    | -      | 0.4  | 20   | $\mu\text{A}$    | $V_{DS} = 650 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25^\circ\text{C}$  |
|                                  |              | -      | 4    | -    |                  | $V_{DS} = 650 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125^\circ\text{C}$ |
| Gate-source leakage current      | $I_{GS}$     | -      | -    | 200  | $\mu\text{A}$    | $V_{GS} = 6 \text{ V}; V_{DS} = 0 \text{ V}$                            |
| Drain-source on-state resistance | $R_{DS(on)}$ | -      | 160  | 200  | $\text{m}\Omega$ | $V_{GS} = 6 \text{ V}; I_D = 3 \text{ A}; T_j = 25^\circ\text{C}$       |
|                                  |              | -      | 330  | -    | $\text{m}\Omega$ | $V_{GS} = 6 \text{ V}; I_D = 3 \text{ A}; T_j = 125^\circ\text{C}$      |
| Gate resistance                  | $R_G$        | -      | 3.5  | -    | $\Omega$         | $f = 5 \text{ MHz}; \text{open drain}$                                  |

**Table 6 Dynamic characteristics**

| Parameters  | Symbols      | Values |      |      | Units       | Notes/Test Conditions   |
|---|--------------|--------|------|------|-------------|---|
|   |              | Min.   | Typ. | Max. |             |   |
| Input capacitance   | $C_{iss}$    | -      | 83   | -    | $\text{pF}$ | $V_{GS} = 0 \text{ V}; V_{DS} = 400 \text{ V}; f = 100 \text{ kHz}$   |
| Output capacitance  | $C_{oss}$    | -      | 27   | -    | $\text{pF}$ | $V_{GS} = 0 \text{ V}; V_{DS} = 400 \text{ V}; f = 100 \text{ kHz}$   |
| Reverse transfer capacitance                              | $C_{rss}$    | -      | 0.4  | -    | $\text{pF}$ | $V_{GS} = 0 \text{ V}; V_{DS} = 400 \text{ V}; f = 100 \text{ kHz}$   |
| Effective output capacitance, energy related <sup>1</sup> | $C_{o(er)}$  | -      | 35   | -    | $\text{pF}$ | $V_{GS} = 0 \text{ V}; V_{DS} = 0 \text{ to } 400 \text{ V}$  |
| Effective output capacitance, time related <sup>2</sup>   | $C_{o(tr)}$  | -      | 54   | -    | $\text{pF}$ | $V_{GS} = 0 \text{ V}; V_{DS} = 0 \text{ to } 400 \text{ V}$  |
| Output charge   | $Q_{oss}$    | -      | 22   | -    | $\text{nC}$ | $V_{GS} = 0 \text{ V}; V_{DS} = 0 \text{ to } 400 \text{ V}$  |
| Turn-on delay time  | $t_{d(on)}$  | -      | 2    | -    | $\text{ns}$ | $V_{DS} = 400 \text{ V}; I_D = 6 \text{ A}; L = 318 \mu\text{H};$<br>$V_{GS} = 6 \text{ V}; R_{on} = 10 \Omega; R_{off} = 2 \Omega$ |
| Turn-off delay time                                       | $t_{d(off)}$ | -      | 4    | -    | $\text{ns}$ |   |
| Rise time   | $t_r$        | -      | 5    | -    | $\text{ns}$ |   |
| Fall time   | $t_f$        | -      | 6    | -    | $\text{ns}$ |   |

1.  $C_{o(er)}$  is the fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V.

2.  $C_{o(tr)}$  is the fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V.



**Table 7 Gate charge characteristics**

| <b>Parameters</b>    | <b>Symbols</b>    | <b>Values</b> |             |             | <b>Units</b> | <b>Notes/Test Conditions</b>   |
|----------------------|-------------------|---------------|-------------|-------------|--------------|--|
|                      |                   | <b>Min.</b>   | <b>Typ.</b> | <b>Max.</b> |              |  |
| Gate charge          | Q <sub>G</sub>    | -             | 2.3         | -           | nC           | V <sub>GS</sub> = 0 to 6 V; V <sub>DS</sub> = 400 V;<br>I <sub>D</sub> = 3 A |
| Gate-source charge   | Q <sub>GS</sub>   | -             | 0.2         | -           | nC           |  |
| Gate-drain charge    | Q <sub>GD</sub>   | -             | 0.9         | -           | nC           |  |
| Gate plateau voltage | V <sub>Plat</sub> | -             | 2.4         | -           | V            |  |

**Table 8 Reverse conduction characteristics**

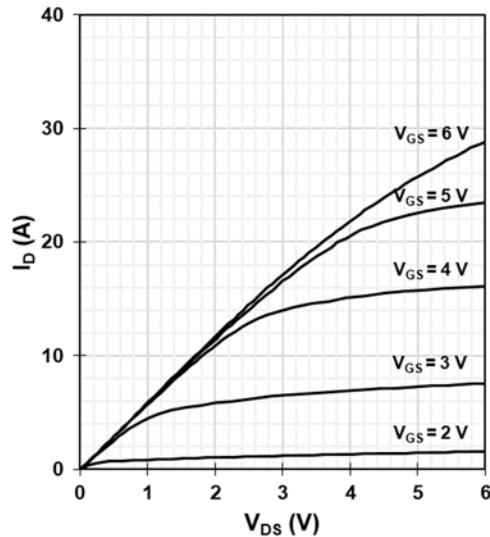
| <b>Parameters</b>             | <b>Symbols</b>         | <b>Values</b> |             |             | <b>Units</b> | <b>Notes/Test Conditions</b>                   |
|-------------------------------|------------------------|---------------|-------------|-------------|--------------|--|
|                               |                        | <b>Min.</b>   | <b>Typ.</b> | <b>Max.</b> |              |  |
| Source-drain reverse voltage  | V <sub>SD</sub>        | -             | 2.5         | -           | V            | V <sub>GS</sub> = 0 V; I <sub>SD</sub> = 3 A   |
| Pulsed current, reverse       | I <sub>S</sub> , pulse | -             | 20          | -           | A            | V <sub>GS</sub> = 6 V                          |
| Reverse recovery charge       | Q <sub>rr</sub>        | -             | 0           | -           | nC           | I <sub>SD</sub> = 3 A; V <sub>DS</sub> = 400 V |
| Reverse recovery time         | t <sub>rr</sub>        | -             | 0           | -           | ns           |  |
| Peak reverse recovery current | I <sub>rrm</sub>       | -             | 0           | -           | A            |  |



## Electrical characteristics diagrams

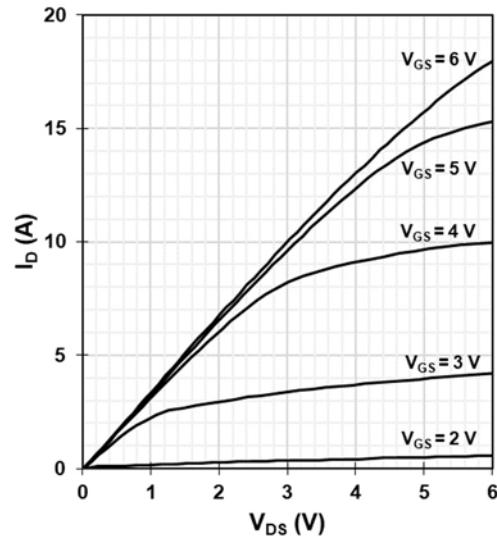
at  $T_j = 25^\circ\text{C}$ , unless specified otherwise.

Figure 1 Typ. output characteristics



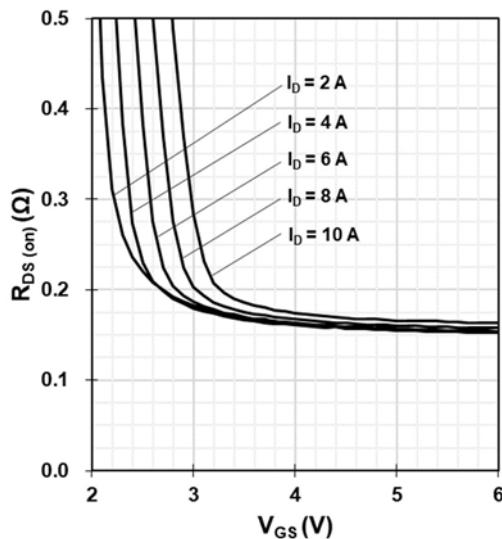
$I_D = f(V_{DS}, V_{GS})$ ;  $T_j = 25^\circ\text{C}$

Figure 2 Typ. output characteristics



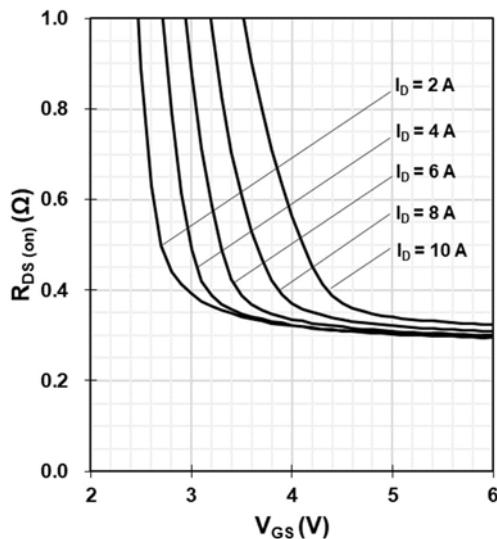
$I_D = f(V_{DS}, V_{GS})$ ;  $T_j = 125^\circ\text{C}$

Figure 3 Typ. drain-source on-state resistance



$R_{DS(on)} = f(I_{DS}, V_{GS})$ ;  $T_j = 25^\circ\text{C}$

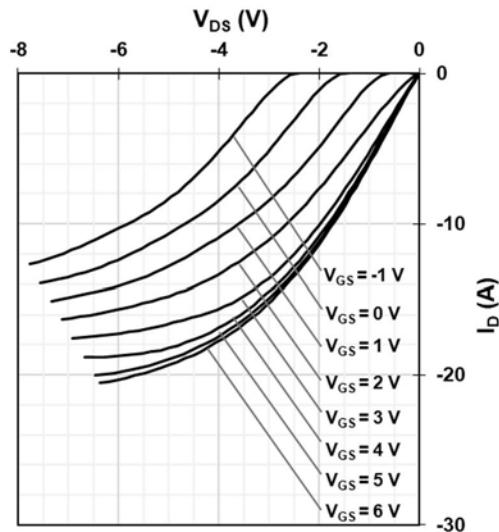
Figure 4 Typ. drain-source on-state resistance



$R_{DS(on)} = f(I_{DS}, V_{GS})$ ;  $T_j = 125^\circ\text{C}$

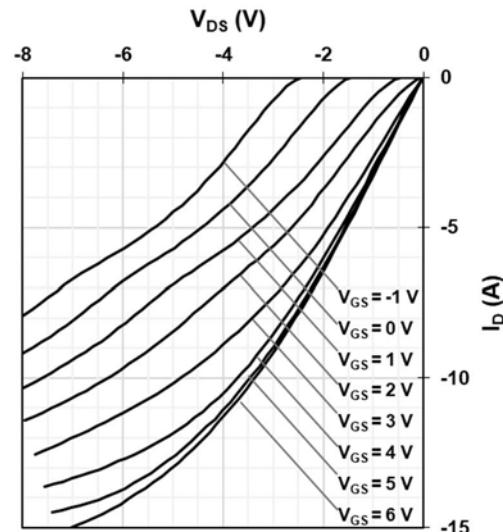


Figure 5 Typ. channel reverse characteristics



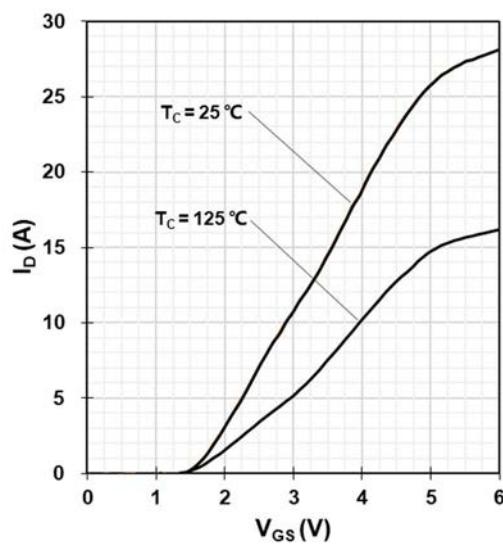
$I_D = f(V_{DS}, V_{GS})$ ;  $T_j = 25^\circ\text{C}$

Figure 6 Typ. channel reverse characteristics



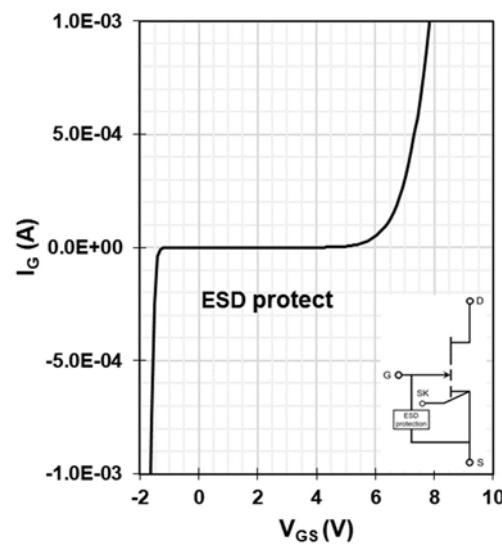
$I_D = f(V_{DS}, V_{GS})$ ;  $T_j = 125^\circ\text{C}$

Figure 7 Typ. transfer characteristics



$I_D = f(V_{GS})$ ;  $V_{DS} = 5\text{ V}$

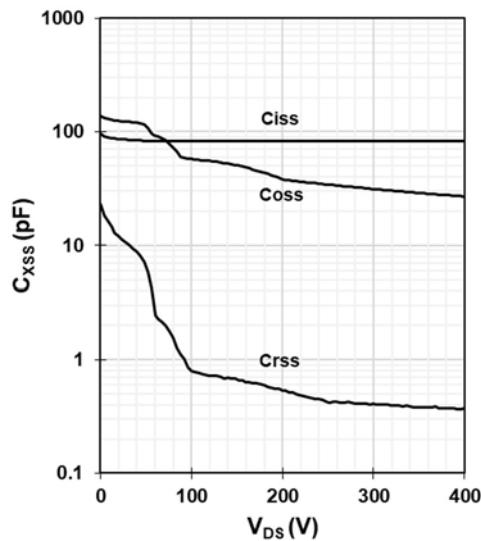
Figure 8 Typ. gate-to-source leakage



$I_G = f(V_{GS})$ ;  $I_G$  reverse turn on by ESD unit;  $V_D = \text{open}$

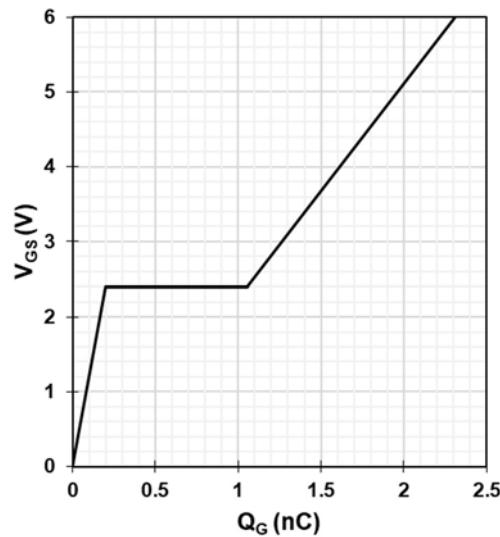


Figure 9 Typ. capacitances



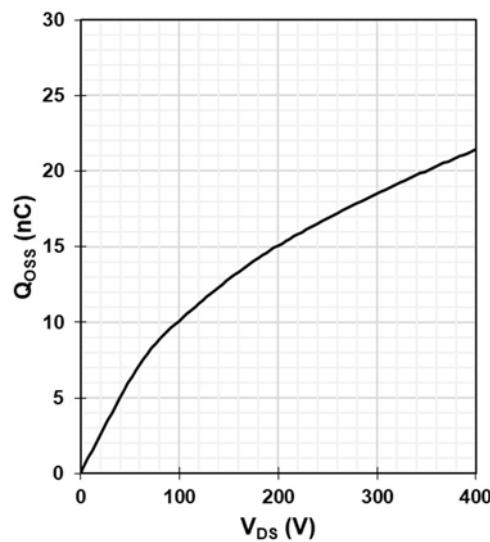
$C_{XSS} = f(V_{DS})$ ; Freq. = 100 kHz

Figure 10 Typ. gate charge



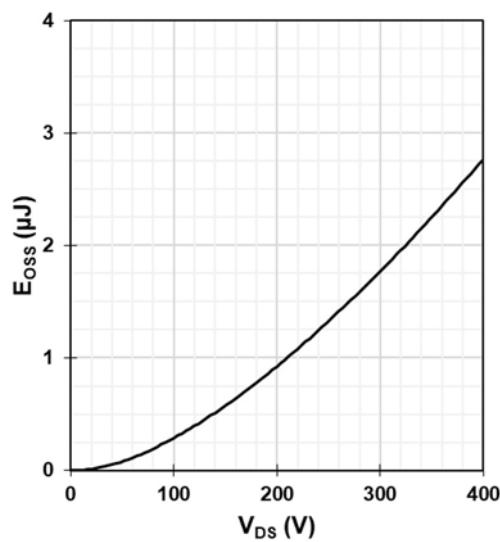
$V_{GS} = f(Q_G)$ ;  $V_{DC-LINK} = 400$  V;  $I_D = 3$  A

Figure 11 Typ. output charge



$Q_{oss} = f(V_{DS})$ ; Freq. = 100 kHz

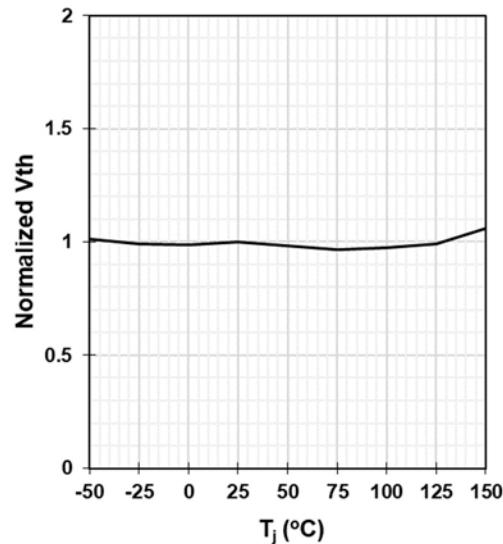
Figure 12 Typ.  $C_{oss}$  stored energy



$E_{oss} = f(V_{DS})$ ; Freq. = 100 kHz

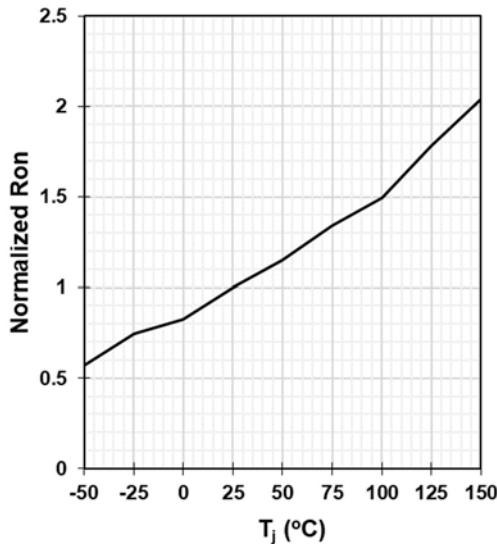


Figure 13 Gate threshold voltage



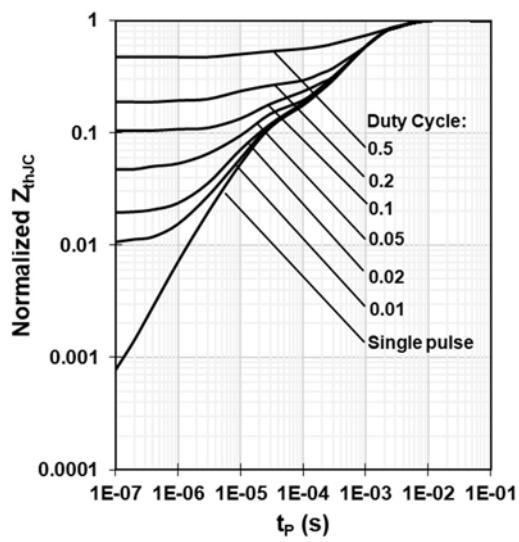
$$V_{th} = f(T_j); V_{GS} = V_{DS}; I_D = 11 \text{ mA}$$

Figure 14 Drain-source on-state resistance



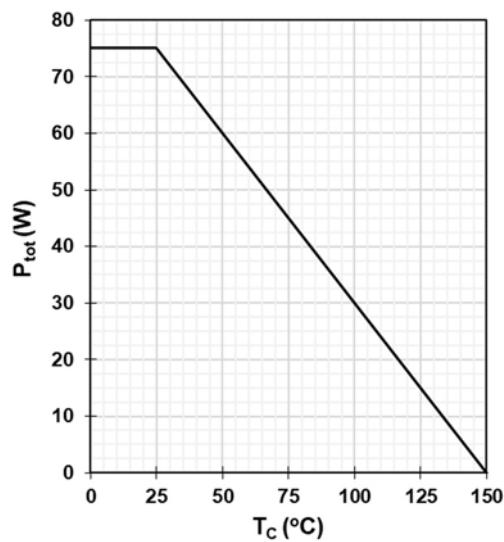
$$R_{DS(on)} = f(T_j); I_D = 3 \text{ A}; V_{GS} = 6 \text{ V}$$

Figure 15 Max. transient thermal impedance



$$Z_{thJC} = f(t_P, D)$$

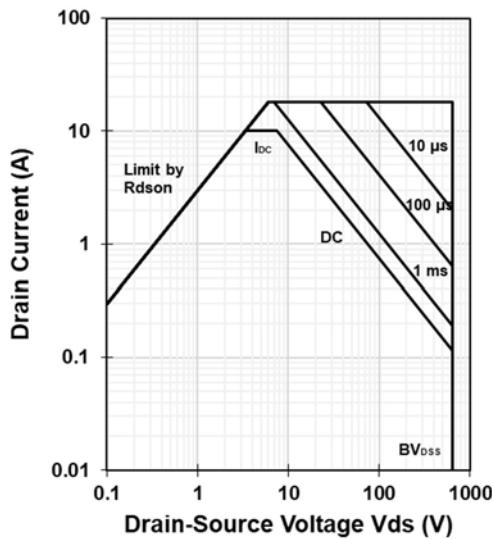
Figure 16 Power dissipation



$$P_{tot} = f(T_c)$$

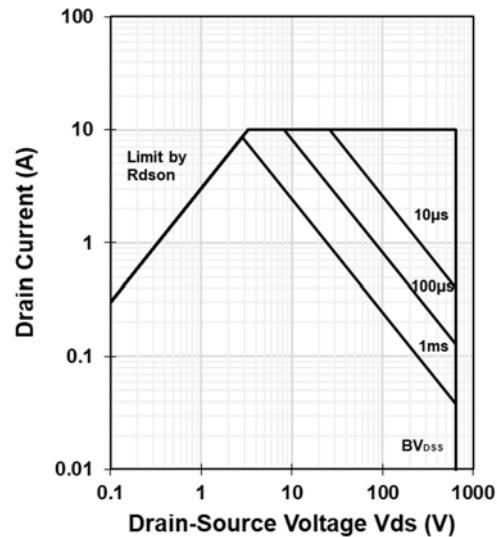


Figure 17 Safe operating area



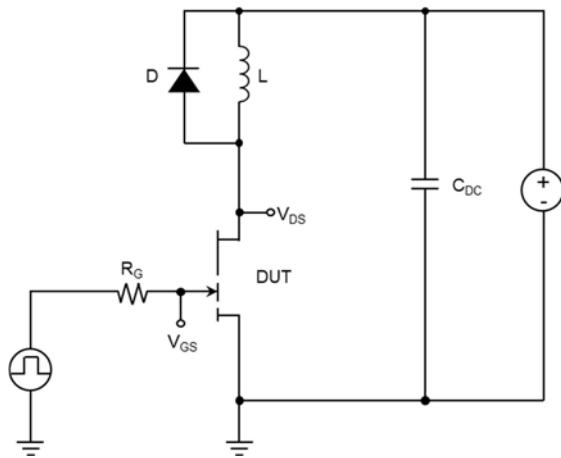
$I_D = f(V_{DS})$ ;  $T_C = 25^\circ\text{C}$

Figure 18 Safe operating area



$I_D = f(V_{DS})$ ;  $T_C = 125^\circ\text{C}$

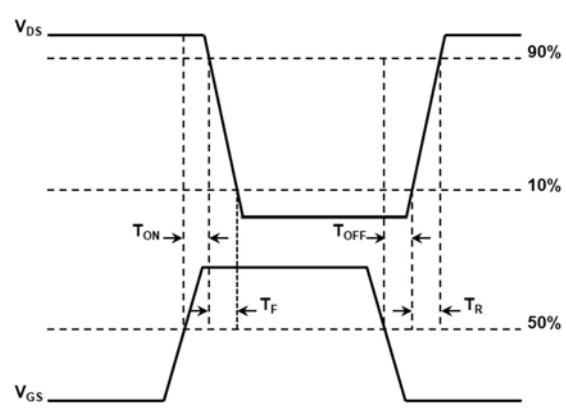
Figure 19 Max. transient thermal impedance



$V_{DS} = 400\text{ V}$ ,  $I_D = 6\text{ A}$ ,  $L = 318\text{ }\mu\text{H}$ ,  $V_{GS} = 6\text{ V}$ ,

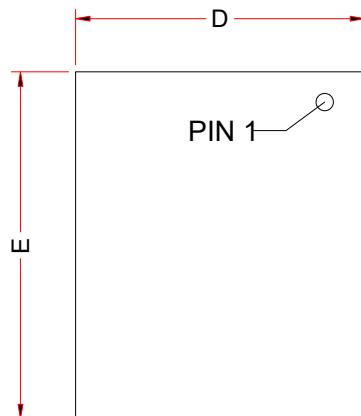
$R_{on} = 10\text{ }\Omega$ ,  $R_{off} = 2\text{ }\Omega$

Figure 20 Typ. switching times waveform

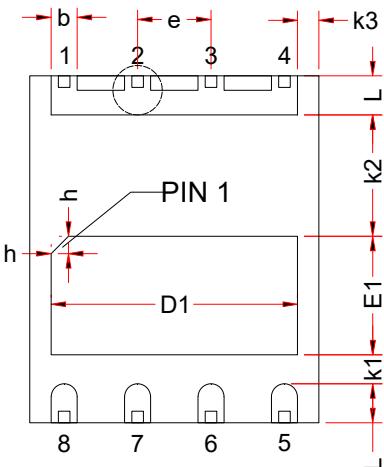




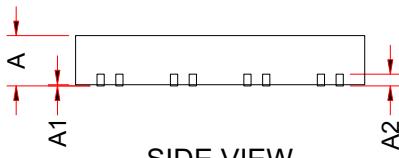
## Package outlines



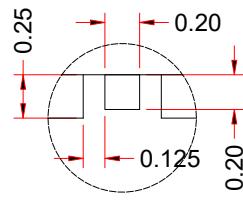
TOP VIEW



BOTTOM VIEW



SIDE VIEW

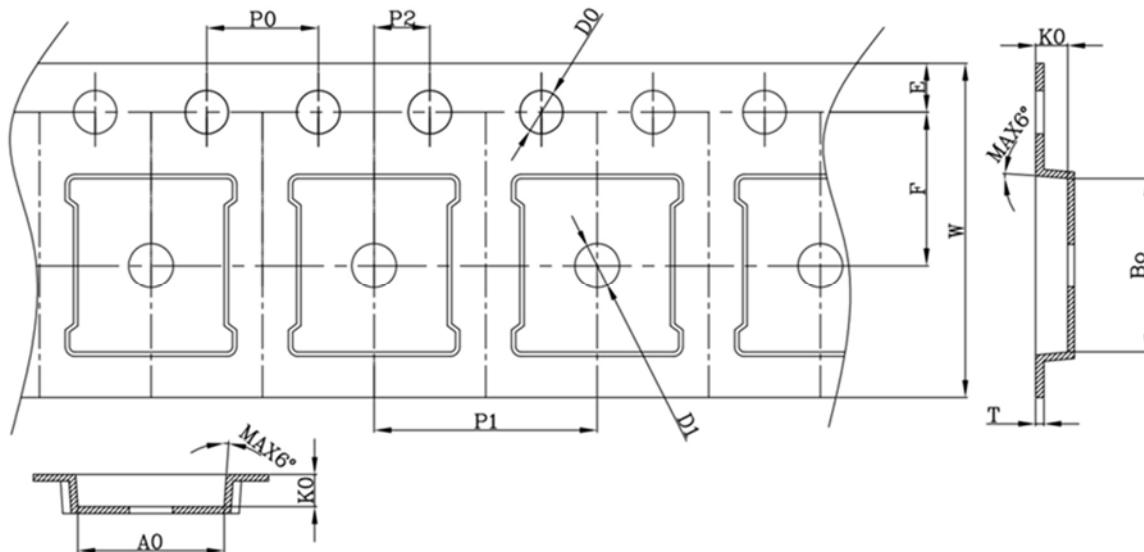


LEAD DETAIL

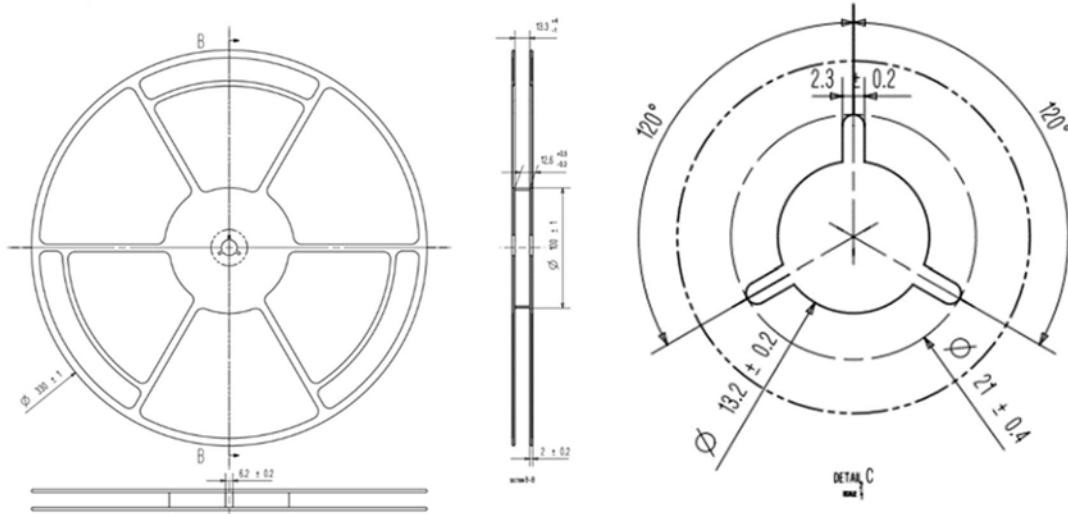
|    | MIN      | MID   | MAX   |
|----|----------|-------|-------|
| A  | 0.75     | 0.85  | 0.95  |
| A1 | 0.00     | 0.02  | 0.05  |
| A2 | 0.203REF |       |       |
| b  | 0.40     | 0.45  | 0.50  |
| D  | 4.90     | 5.00  | 5.10  |
| D1 | 4.16     | 4.26  | 4.36  |
| E  | 5.90     | 6.00  | 6.10  |
| E1 | 1.95     | 2.05  | 2.15  |
| h  | 0.20     | 0.30  | 0.40  |
| L  | 0.575    | 0.675 | 0.775 |
| e  | 1.270BSC |       |       |
| k1 | 0.400MIN |       |       |
| k2 | 2.000MIN |       |       |
| k3 | 0.270MIN |       |       |



## Reel information



| SYMBOL | DIMENSION  | SYMBOL | DIMENSION  |
|--------|------------|--------|------------|
| W      | 12.00±0.30 | 10P0   | 40.00±0.20 |
| E      | 1.75±0.10  | P1     | 8.00±0.10  |
| F      | 5.50±0.05  | A0     | 5.25±0.10  |
| D0     | 1.55±0.05  | B0     | 6.25±0.10  |
| D1     | 1.55±0.10  | K0     | 1.15±0.10  |
| P0     | 4.00±0.10  | T      | 0.25±0.05  |
| P2     | 2.00±0.05  |        |            |





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